# PATENT ASSIGNMENT

## Electronic Version v1.1 Stylesheet Version v1.1

SUBMISSION TYPE: NEW ASSIGNMENT

NATURE OF CONVEYANCE: ASSIGNMENT

#### **CONVEYING PARTY DATA**

Name	Execution Date		
WIPAWAN WONGDAO	05/18/2010		
YONGYUT WONGBUNNAK	05/18/2010		

## **RECEIVING PARTY DATA**

Name:	WESTERN DIGITAL TECHNOLOGIES, INC.		
Street Address:	20511 LAKE FOREST DRIVE		
City: LAKE FOREST			
State/Country:	CALIFORNIA		
Postal Code:	92630		

#### PROPERTY NUMBERS Total: 1

Property Type	Number			
Application Number:	12750472			

## **CORRESPONDENCE DATA**

Fax Number: (949)672-6604

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Correspondent Name: WESTERN DIGITAL

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Address Line 2: 20511 LAKE FOREST DRIVE

Address Line 4: LAKE FOREST, CALIFORNIA 92630

ATTORNEY DOCKET NUMBER: T4083

NAME OF SUBMITTER: Andrew D. Mickelsen, Reg. No. 50,957

**Total Attachments: 3** 

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PATENT REEL: 024475 FRAME: 0876

Atty. Docket No.: T4083

## **ASSIGNMENT**

Whereas, we, WIPAWAN WONGDAO, a citizen of Thailand, residing at Bang Pa-in, Thailand; and YONGYUT WONGBUNNAK a citizen of Thailand, residing at Samutprakarn, Thailand, have invented certain new and useful improvements in CORRELATION STANDARD FOR CALIBRATING A SCANNING ELECTRON MICROSCOPE (hereafter "Improvements") for which we have executed an application for a United States Patent filed March 30, 2010, Application No. 12/750,472 (hereafter "Application"); and

Whereas, Western Digital Technologies, Inc. (hereafter "Assignee"), a Delaware Corporation, desires to acquire the entire right, title, and interest in and to the Improvements and the Application.

Now, therefore, that for good and valuable consideration, the receipt of which is hereby acknowledged, we hereby acknowledge that we have sold, assigned, transferred and set over, and by these presents do hereby sell, assign, transfer and set over, unto the Assignee, its successors, legal representatives and assignees, the entire right, title, and interest throughout the world in, to and under the Improvements, and the Application and all divisions, renewals and continuations thereof, and all Letters Patent of the United States which may be granted thereof and all reissues and extensions thereof, and all rights of priority under International Conventions and applications for Letters Patent which may hereafter be filed for the Improvements in any country or countries foreign to the United States and all extensions, renewals and reissues thereof; and we hereby authorize and request the Commissioner of Patents of the United States, and any Official of any country or countries foreign to the United States, whose duty it is to issue patents on applications as aforesaid, to issue all Letters Patents for the Improvements to the Assignee, its successors, legal representatives and assigns, in accordance with the terms of this instrument.

We hereby covenant and agree that we will communicate to the Assignee, its successors, legal representatives and assigns, any facts known to me respecting the Improvements, and testify in any legal proceeding, sign all lawful papers, execute all divisional, continuing and reissue applications, make all rightful oaths and aid the Assignee, its successors, legal representatives and assigns, to obtain and enforce proper patent protection for the Improvements in all countries.

Title	of	Invention:	CORRELATION	STANDARD	FOR	CALIBRATING	A	SCANNING	G
FIEC	GTP <sup>*</sup>	ON MICROS	COPE	*,	100				

May 18 /2010

Date X

Witnessed by:

Mugfa K.
Type/Print 1st Witness Name

DLIANGFORN SOMPONGS E Type/Print 2nd Witness Name

Witness Signature

May 18 2010

Date

Date

Hay 18 2010

Witness Signature

Date

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Title of Invention: CORRELATION STANDARD FOR CALIBRATING A SCANNING

**ELECTRON MICROSCOPE** 

YONGYUT WONGBUNNAK

Witnessed by:

Witness Signature

DUANGPORN SOMPONGSE

Type/Print 2nd Witness Name

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**RECORDED: 06/02/2010**